

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/763,339	FEASTER ET AL.	
Examiner	Art Unit	
Bin Shen	1657	

	SEAR	CHED	
Class	Subclass	Date	Examiner

INI	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
updated search.	8/27/2007	BS	